

Notice of References Cited	Application/Control No. 10/553,284		Applicant(s)/Patent Under Reexamination SCHULZ ET AL.	
	Examiner WILLIAM P. BELL		Art Unit 1791	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,071,597 A	12-1991	D'Amato et al.	264/1.34
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	N	JP 05045503 A	02-1993	Japan	NAKANO et al.	G02B 01/12
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NON-PATENT DOCUMENTS

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	U	Veeco Ion Beam Equipment Inc., "Mark II+ High Output Ion Source" Data Sheet, http://www.veeco.com/pdfs/datasheets/062794%20b_vc%20mark%20ii%20hces%20ds.pdf
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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